

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE					ATTY. DOCKET NO. MI22-2381	SERIAL NO. Filed Herewith	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)					APPLICANT Leonard Forbes	SN. 10/638,171	
					FILING DATE Filed Herewith	GROUP Unknown 2818	
U.S. PATENT DOCUMENTS							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
W	AA	5,285,687	10/1998	Yin			
W	AB	5,754,468	5/1998	Hobson			
W	AC	6,011,726	1/4/2000	Batson et al.			
W	AD	6,104,045	8/2000	Forbes et al			
W	AE	6,128,216	10/2000	Noble, Jr. Et al.			
W	AF	6,194,759 B1	2/2001	Sano et al.			
W	AG	6,255,165	5/2001	Noble, Jr. et al.			
W	AH	6,287,913	9/2001	Agnello et al.			
W	AI	6,342,718 B1	1/2002	Noble	Viet Q. Nguyen Primary Examiner		
W	AJ	6,459,113 B1	10/2002	Moribara et al.			
W	AK	6,275,433 B1	8/14/2001	Forbes			
W	AL	6,519,197	02/11/2003	Forbes			
W	AM	2002/0028550 A1	3/2002	Moribara et al./Pub.App			
W	AN	2003/0076721	4/24/03	Forbes Pub. App.			
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
W	AO	JP2001308298A	11/2001	Hoffman			Yes
W	AP	JP410335488A	12/1998	William et al.			No
AO							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
W	AR	Lage et al., Advanced SRAM technology - the race between 4T and 6T cells," Abstract (Web address - http://photon.ei.org).					
		Technical Digest - Proceedings of the 1996 IEEE International Electron Devices Meeting Dec. 8-11, 1996.					
W	AS	Noda et al., A 1.9- μ m ² Loadless CMOS Four-Transistor SRAM Cell in a 0.18- μ m Logic Technology, date unknown.					
		ULSI Device Development Laboratories, NEC Corporation, Japan, 5 pages.					
W	AT						
EXAMINER	V. Nguyen		DATE CONSIDERED		6/22/04		
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vn	AA	6,184,588	2/2001	Kim et al.				
vn	AB	5,774,392	6/1998	Kraus et al.				
vn	AC	6,212,102	4/2001	Georgakos et al.				
vn	AD	6,265,266	7/2001	Dejenfelt et al.				
vn	AE	5,388,068	2/1995	Ghoshal et al.				
vn	AF	5,754,010	5/1998	Ceravella et al.				
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Form PTO-1449

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Leonard ForbesFILING DATE
August 8, 2003GROUP
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*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
WJ	AA	6,090,648	7/18/2000	Reedy et al.			
WJ	AB	6,448,601 B1	9/10/2002	Forbes et al.			
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	AD						
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	AF						
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	AH			Viet Q. Nguyen Primary Examiner			
	AI						
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FOREIGN PATENT DOCUMENTS

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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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Viet Q. Nguyen
Primary Examiner

EXAMINER

V. Nguyen

DATE CONSIDERED

6/22/09

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Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
<i>LN</i>	AA	6,605,961	8/2003	Forbes, Leonard			
<i>LN</i>	AD	6,449,186	9/2002	Noble, Wendell P.			
<i>LN</i>	AC	6,057,535	5/2000	Riedy et al.			
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